

Notice of References Cited	Application/Control No. 10/519,800		Applicant(s)/Patent Under Reexamination HIEDA ET AL.	
	Examiner David J. Joy		Art Unit 1774	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-7,161,588	01-2007	Nakanishi et al.	345/173
*	B	US-2002/0122925	09-2002	Liu et al.	428/212
*	C	US-2003/0104210	06-2003	Azumi et al.	428/411.1
*	D	US-2001/0037935	11-2001	Oya et al.	200/512
*	E	US-5,847,795	12-1998	Satoh et al.	349/137
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	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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